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ABSTRACT OF THE DISCLOSURE

It is an object to provide an electrode structure of a carrier substrate of a semiconductor device in which the strength and the reliability of the joint portion between an electrode of a semiconductor package and an electrode of a main substrate are improved. A soldering land (103) that is an electrode of a carrier substrate (102) is hemispheric having a concentric hemispheric face hollow portion thereinside, а flange portion is provided in circumferential portion thereof, and the outer diameter of the flange portion corresponds to the outer diameter of the conventional cylinder. Two slits (104) are provided in the flange portion and parts of a wall surface adjacent to the flange portion for venting air. A hemispheric face recess is provided in the carrier substrate (102) toward an outer surface, and the soldering land (103) is fixedly attached to the carrier substrate (102) so that the soldering land (103) is fitted into the recess and the flange portion abuts the outer surface of the carrier substrate.